(Sea	arc	ch	No	te	es.
111	1818	18111		11111	11111	



Application/Control No.	Applicant(s)/Patent under Reexamination
09/842,370	WIESLER ET AL.
Examiner	Art Unit
Chongshan Chen	2162

	SEAR	CHED	
Class	Subclass	Date	Examiner
707	100	8/4/2005	cc
700	90	8/4/2005	CC

INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
		-	
			<u></u>

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
PALM	8/4/2005	CC
EAST search (USPAT, US-PGPUB, IBM_TDB)	8/4/2005	cc
consulted with Jean M. Corrielus	7/28/2005	сс